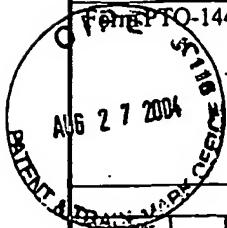


Sheet 1 of 1

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Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date if appropriate
ET	A. 4,313,084	01/26/1982	Hosokawa, et al.			
ET	B. 4,562,511	12/31/1985	Nishino, et al.	361	364	
ET	C. 6,195,252	02/27/2001	Belyakov, et al.	701	502	
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ET	G. WO97/07518	02/27/97				

FOREIGN PATENT DOCUMENTS

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ET	H. 2-11008		Japan			

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, etc.)

- ET 1. Volkovich, Y., M. and Bagotsky, V.S., "The Method of Standard Porosimetry," *J. Power Sources* 48: 327-339 (1994).

Examiner Signature: ETDate Considered: 3/4/05

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered.

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